

General Description

The Sanrise SRT10N230L is a low voltage power MOSFET, fabricated using advanced split gate trench technology. The resulting device has extremely low on resistance, low gate charge and fast switching time, making it especially suitable for applications which require superior power density and synchronous rectification.

The SRT10N230L break down voltage is 100V and it has a high rugged avalanche characteristics. The SRT10N230L is available in SOP-8 and TO-252 packages.

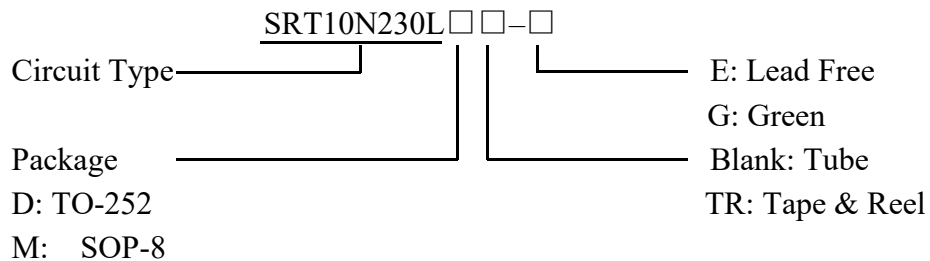
Features

- Ultra Low $R_{DS(ON)}$ $TYP = 18.5m\Omega @ V_{GS} = 10V$.
- Ultra Low Gate Charge, $Q_g = 11.3nC$ typ.
- Fast switching capability
- Robust design with better EAS performance
- Features Add Non-automotive Qualified

Application

- Charger/Adapter
- DC/DC Power Supply
- E-Tools
- BMS

Ordering Information



Symbol

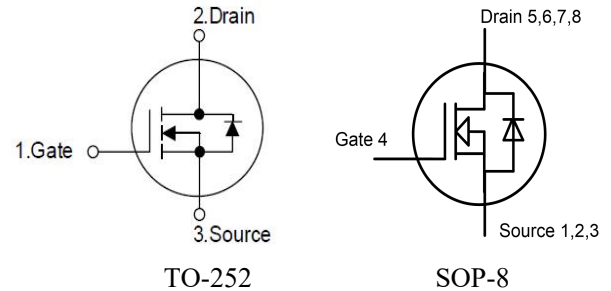


Figure 1 Symbol of SRT10N230L

Package Type

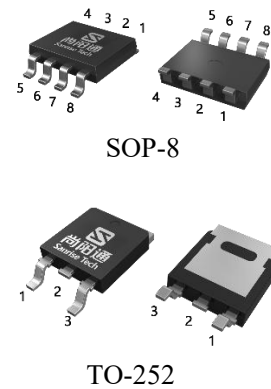


Figure 2 Package Type of SRT10N230L

Package	Part Number	Marking ID	Packing Type
SOP-8	SRT10N230LMTR-G	10N230LMG	Tape & Reel
TO-252	SRT10N230LDTR-G	SRT10N230LDG	Tape&Reel

Absolute Maximum Ratings

Parameter		Symbol	Rating		Unit
Drain-Source Voltage		V_{DSS}	100		V
Gate-Source Voltage		V_{GSS}	± 20		V
Continuous Drain Current	$T_C = 25^\circ\text{C}$	I_D	TO-252	30	A
	$T_A = 25^\circ\text{C}$		SOP8	5.9	
	$T_C = 100^\circ\text{C}$		TO-252	19	
	$T_A = 100^\circ\text{C}$		SOP8	3.7	
Pulsed Drain Current (Note 2)		I_{DM}	87		A
Power Dissipation ($T_C = 25^\circ\text{C}$)		P_D	36		W
Avalanche Destructive Energy, Single Pulse (Note 4)		E_{AS_Limit}	56.25		mJ
Avalanche Energy, Single Pulse (Note 3)		E_{AS}	12.25		mJ
Avalanche Energy, Repetitive (Note 2)		E_{AR}	0.1		mJ
Avalanche Current, Repetitive (Note 2)		I_{AR}	13		A
Continuous Diode Forward Current		I_S	29		A
Diode Pulse Current		I_{S_PULSE}	87		A
Operating Junction Temperature		T_J	150		$^\circ\text{C}$
Storage Temperature		T_{STG}	-55 to 150		$^\circ\text{C}$
Lead Temperature (Soldering, 10 sec)		T_{LEAD}	260		$^\circ\text{C}$

Note:

1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.
2. Repetitive Rating: Pulse width limited by maximum junction temperature
3. $I_{AS} = 7.0\text{A}$, $V_{DD} = 50\text{V}$, $R_G = 25\Omega$, Starting $T_J = 25^\circ\text{C}$
4. $I_{AS_Limit} = 15.0\text{A}$, $V_{DD} = 50\text{V}$, $R_G = 25\Omega$, Starting $T_J = 25^\circ\text{C}$

Thermal Resistance

Parameter		Symbol	Min	Typ	Max	Unit
Thermal Resistance, Junction-to-Lead	SOP8	R_{thJL}			25	$^\circ\text{C/W}$
Thermal Resistance, Junction-to-Case	TO-252	R_{thJC}			3.1	$^\circ\text{C/W}$
Thermal Resistance, Junction-to-Ambient	SOP8	R_{thJA}			80	$^\circ\text{C/W}$
Thermal Resistance, Junction-to-Ambient	TO-252	R_{thJA}			62	$^\circ\text{C/W}$

Electrical Characteristics

$T_J = 25^\circ\text{C}$, unless otherwise specified.

Parameter		Symbol	Test Conditions	Min	Typ	Max	Unit
Statistic Characteristics							
Drain-Source Breakdown Voltage		BV _{DSS}	V _{GS} =0V, I _D =250uA	100			V
Zero Gate Voltage Drain Current		I _{DSS}	V _{DS} =100V, V _{GS} =0V			1	uA
Gate-Body Leakage Current	Forward	I _{GSSF}	V _{GS} =20V, V _{DS} =0V			100	nA
	Reverse	I _{GSSR}	V _{GS} =-20V, V _{DS} =0V			-100	
Gate Threshold Voltage		V _{GS(TH)}	V _{DS} =V _{GS} , I _D =0.25mA	1.2	1.8	2.4	V
Static Drain-Source On-Resistance		R _{DS(ON)}	V _{GS} =4.5V, I _D =15A		25.9	34	mΩ
Static Drain-Source On-Resistance		R _{DS(ON)}	V _{GS} =10V, I _D =15A		18.5	23	mΩ
Gate Resistance		R _G	f=1MHz, Open Drain		1.3		Ω
Dynamic Characteristics							
Input Capacitance		C _{ISS}	V _{DS} =50V, V _{GS} =0V, f=1MHz		749		pF
Output Capacitance		C _{OSS}			218		pF
Reverse Transfer Capacitance		C _{RSS}			4		pF
Effective output capacitance, energy related ^{NOTE5}		C _{O(er)}	V _{GS} =0V, V _{DS} =0...60V		295		pF
Effective output capacitance, time related ^{NOTE6}		C _{O(tr)}			347		
Turn-on Delay Time		t _{d(on)}	V _{DD} =50V, I _D =15A R _G =3.0Ω, V _{GS} =10V		5.6		nS
Rise Time		t _r			4.1		
Turn-off Delay Time		t _{d(off)}			12.1		
Fall Time		t _f			2.8		
Gate Charge Characteristics							
Gate to Source Charge		Q _{gs}	V _{DD} =50V, I _D =15A V _{GS} =0 to 4.5V		2.4		nC
Gate to Drain Charge		Q _{gd}			2.0		
Gate Charge Total		Q _g			5.6		
Gate Charge Total		Q _g	V _{DD} =50V, I _D =15A V _{GS} =0 to 10V		11.3		nC
Gate Charge Total, sync FET		Q _g	V _{DD} =0.1V, V _{GS} =0 to 10V		10.0		nC
Reverse Diode Characteristics							
Drain-Source Diode Forward Voltage		V _{SD}	V _{GS} =0V, I _{SD} =15A		0.9	1.1	V
Reverse Recovery Time		t _{rr}	V _R =50V, I _F =15A dI _F /dt=100A/us		21		nS
Reverse Recovery Charge		Q _{rr}			17		nC
Peak Reverse Recovery Current		I _{rrm}			1.6		A

Note:

- $C_{O(er)}$ is a fixed capacitance that gives the same stored energy as C_{OSS} while V_{DS} is rising from 0 to 60V
- $C_{O(tr)}$ is a fixed capacitance that gives the same charging time as C_{OSS} while V_{DS} is rising from 0 to 60 V

Typical Performance Characteristics

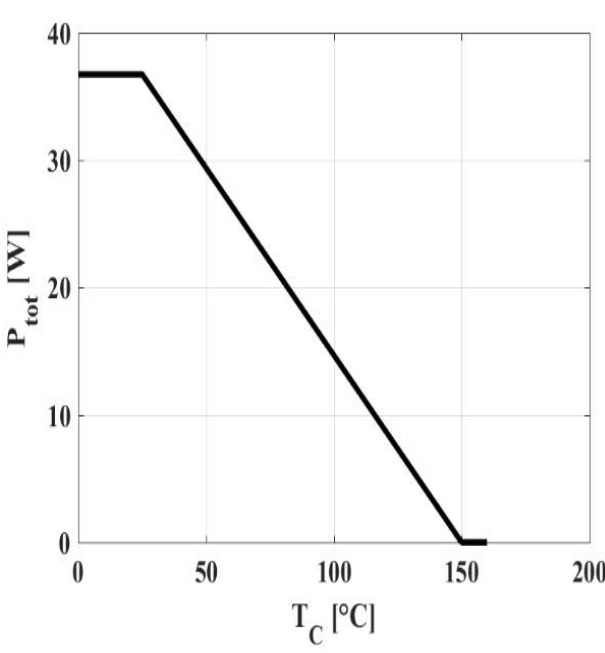
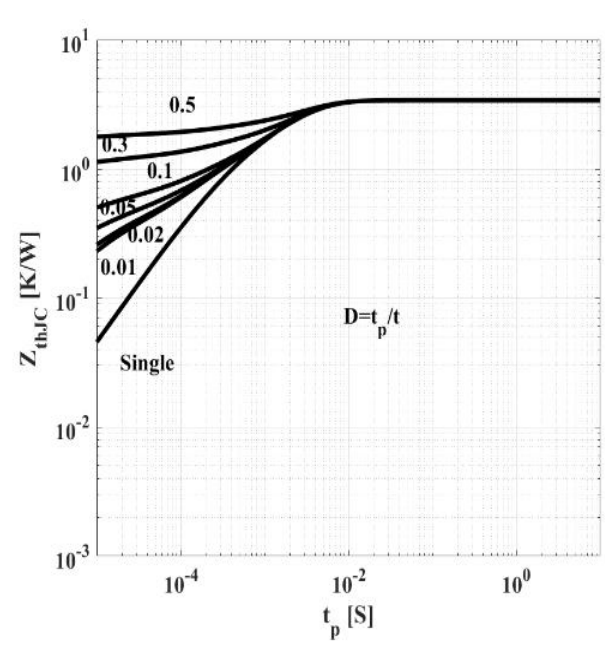
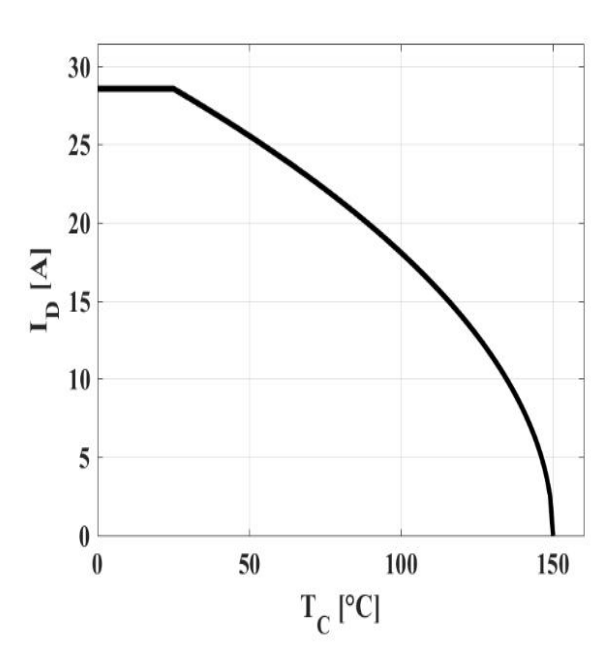
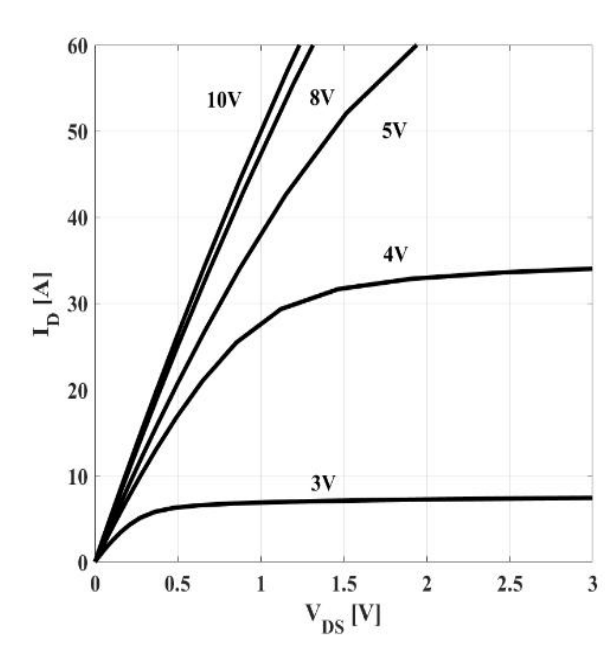
Figure 3: Power Dissipation  $P_{tot}=f(T_C)(\text{DFN5*6})$	Figure 4: Max. Transient Thermal Impedance  $Z_{(th)JC}=f(t_p)$;parameter:$D=t_p/T$ (DFN5*6)
Figure5: Drain Current  $dI_D=f(T_C);V_{GS}\geq 10V(\text{DFN5*6})$	Figure6: Typ. Output Characteristics  $I_D=f(V_{DS});T_j=25^{\circ}C$; parameter:$V_{GS}$

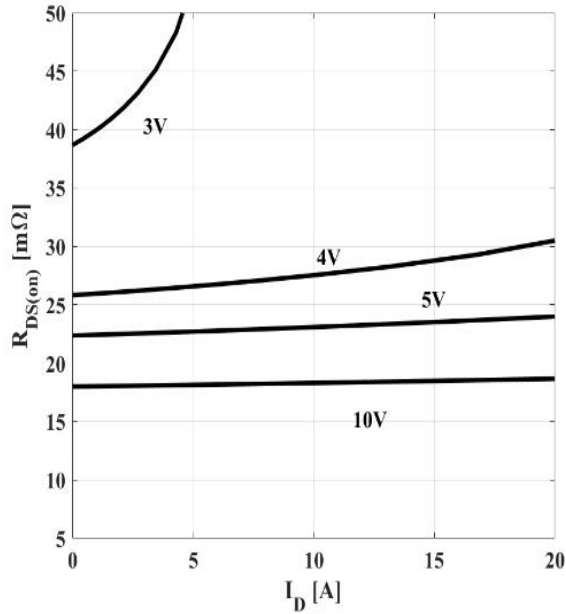
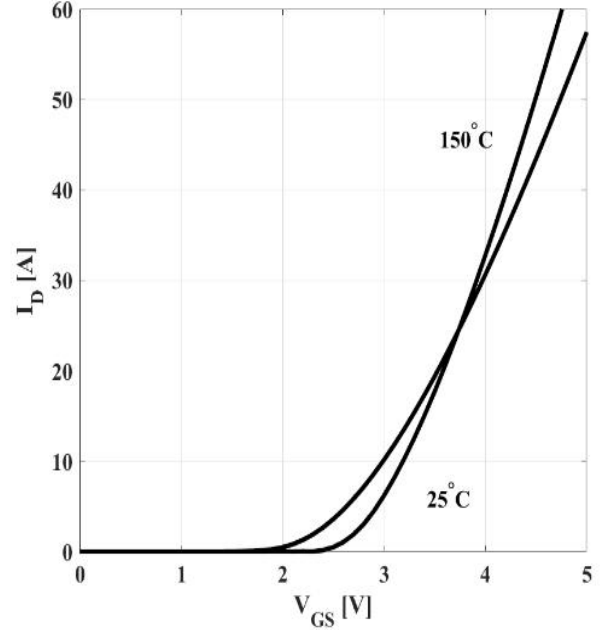
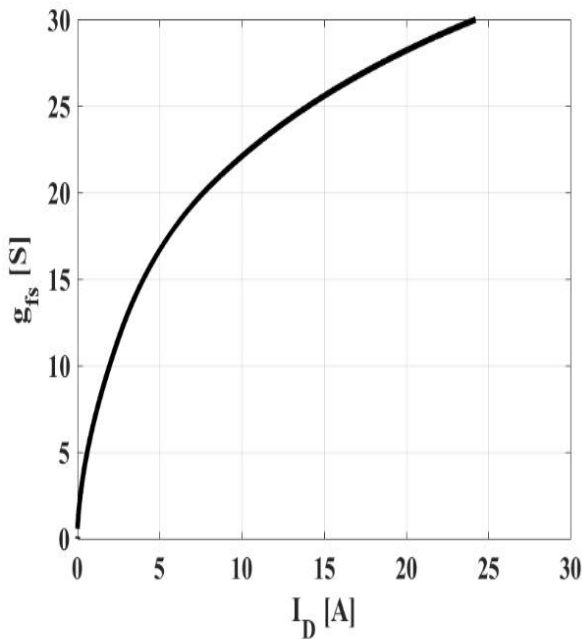
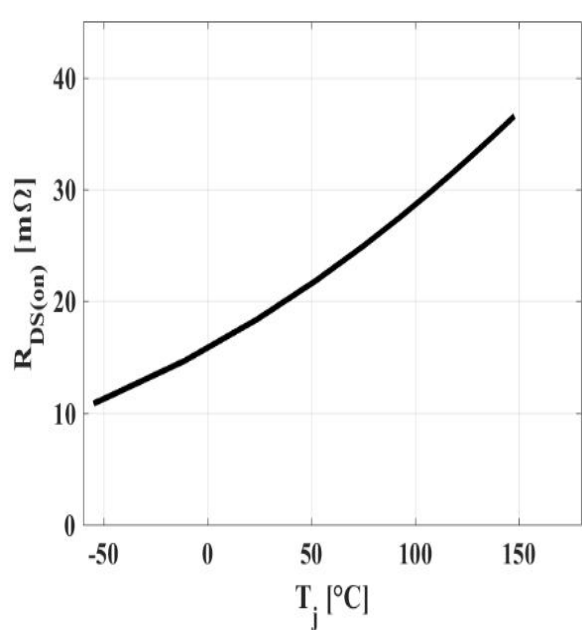
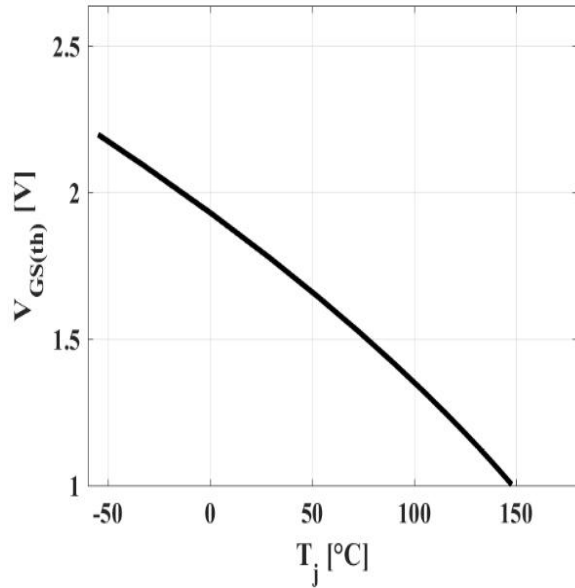
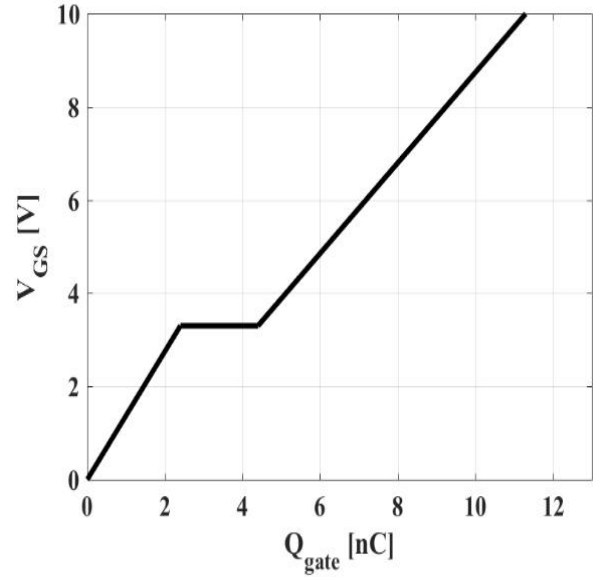
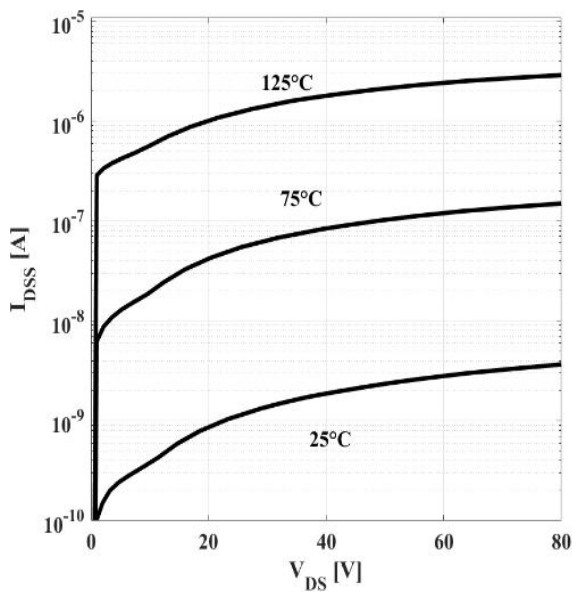
Figure7: Typ. Drain-Source On-State Resistance

 $R_{DS(ON)}=f(I_D); T_j=25^{\circ}\text{C}; \text{parameter: } V_{GS}$
Figure8: Typ. Transfer Characteristics

 $I_D=f(V_{GS}); |V_{DS}|>2|I_D|R_{DS(on)max}; \text{parameter: } T_j$
Figure9: Typ. Forward Transconductance

 $g_{fs}=f(I_D); T_j=25^{\circ}\text{C}$
Figure10: Typ. Drain-Source On-State Resistance

 $R_{DS(ON)}=f(T_j); I_D=15\text{A}; V_{GS}=10\text{V}$

Figure 11: Typ. Gate Threshold Voltage


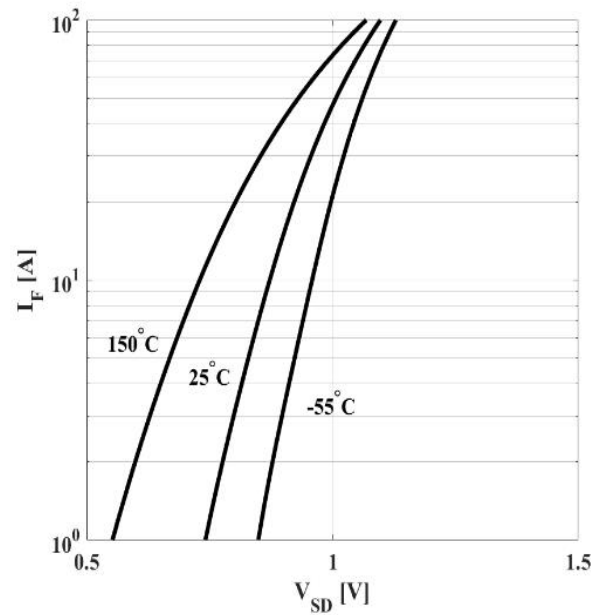
$$V_{GS(th)} = f(T_j); V_{GS} = V_{DS}; I_{DS} = 250\mu A$$

Figure 12: Typ. Gate Charge


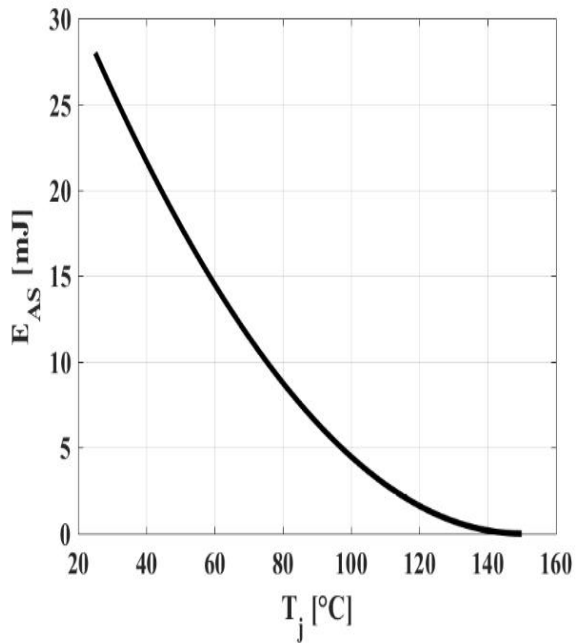
$$V_{GS} = f(Q_{gate}), I_D = 15A \text{ pulsed}$$

Figure 13: Drain-Source Leakage Current


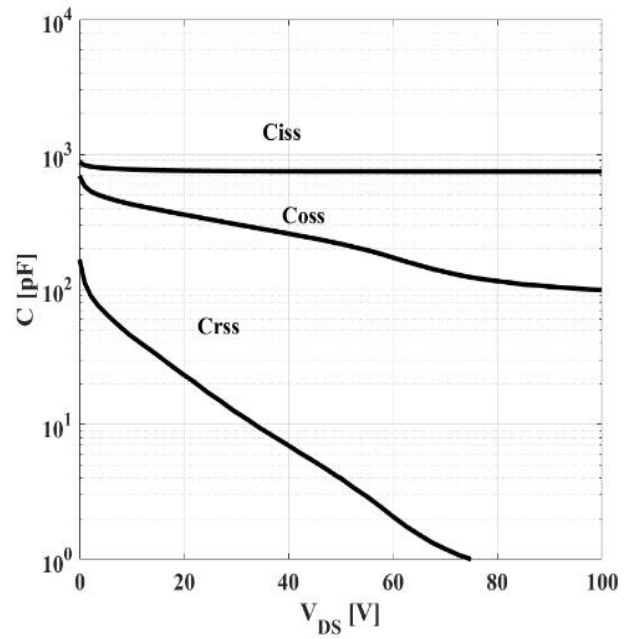
$$I_{DSS} = f(V_{DS}); V_{GS} = 0V; \text{parameter: } T_j$$

Figure 14: Forward Characteristics of Reverse Diode


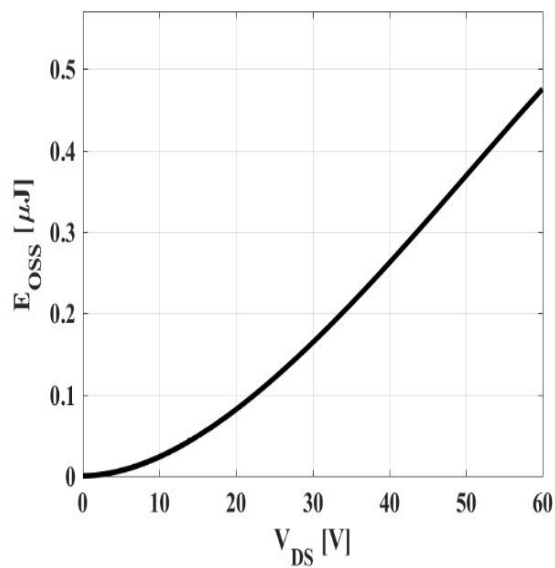
$$I_F = f(V_{SD}); \text{parameter: } T_j$$

Figure 15: Avalanche Energy


$$E_{AS}=f(T_j); I_D=13.0A; V_{DD}=50V$$

Figure 16: Typ. Capacitances


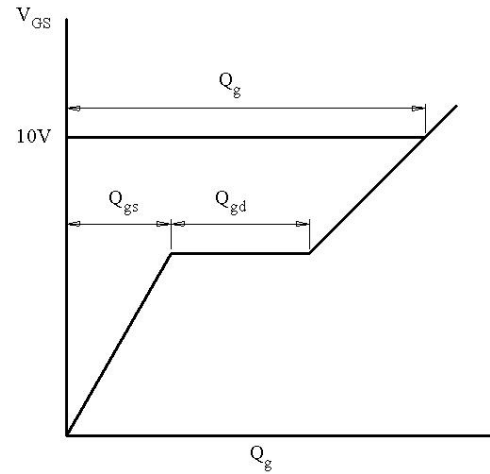
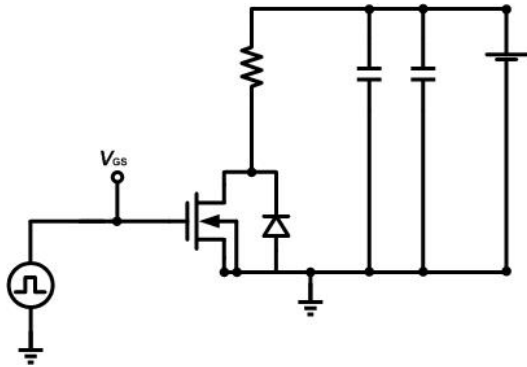
$$C=f(V_{DS}); V_{GS}=0; f=1MHz$$

Figure 17: Coss Stored Energy


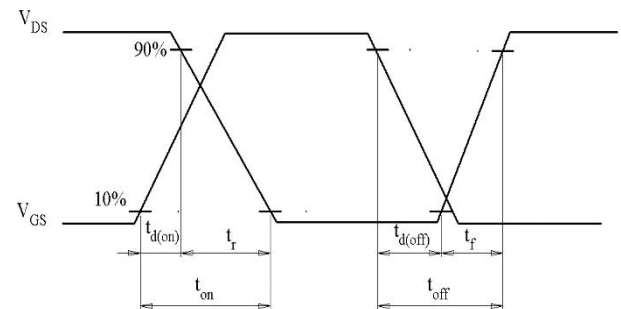
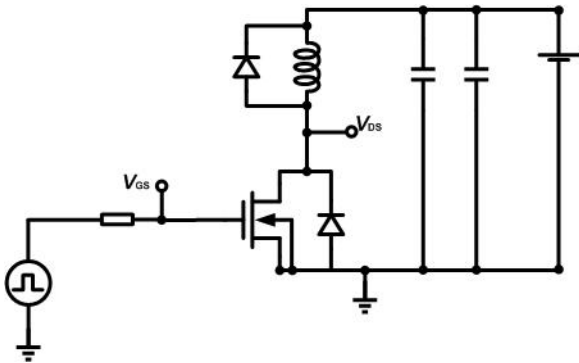
$$E_{OSS}=f(V_{DS})$$

Test Circuits

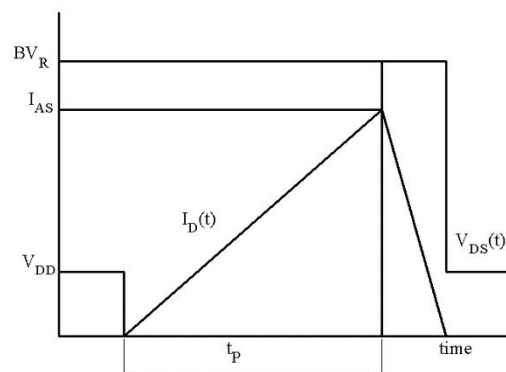
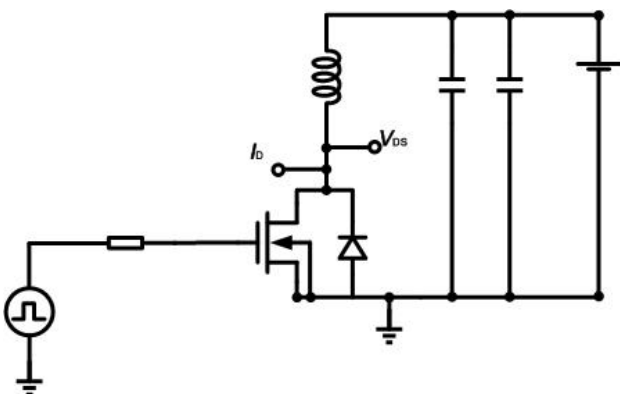
1. Gate Charge Test Circuit & Waveform



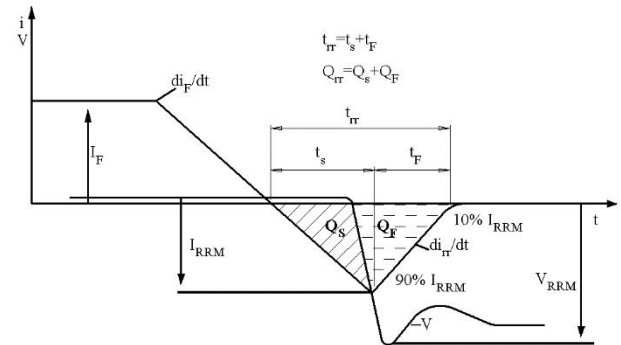
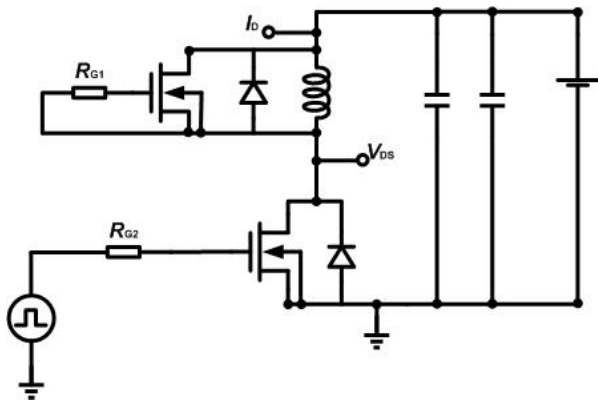
2. Switch Time Test Circuit



3. Unclamped Inductive Switching Test Circuit & Waveforms



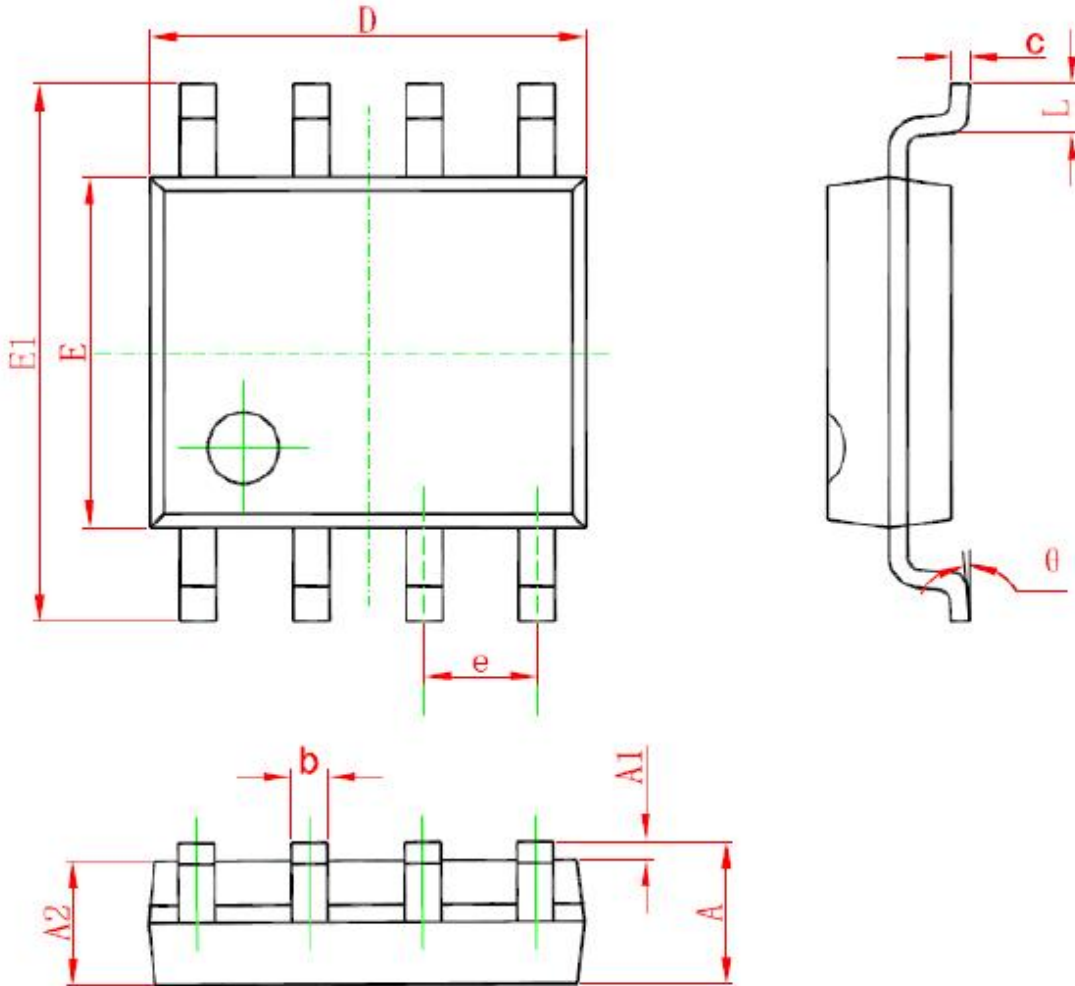
4. Test Circuit and Waveform for Diode Characteristics



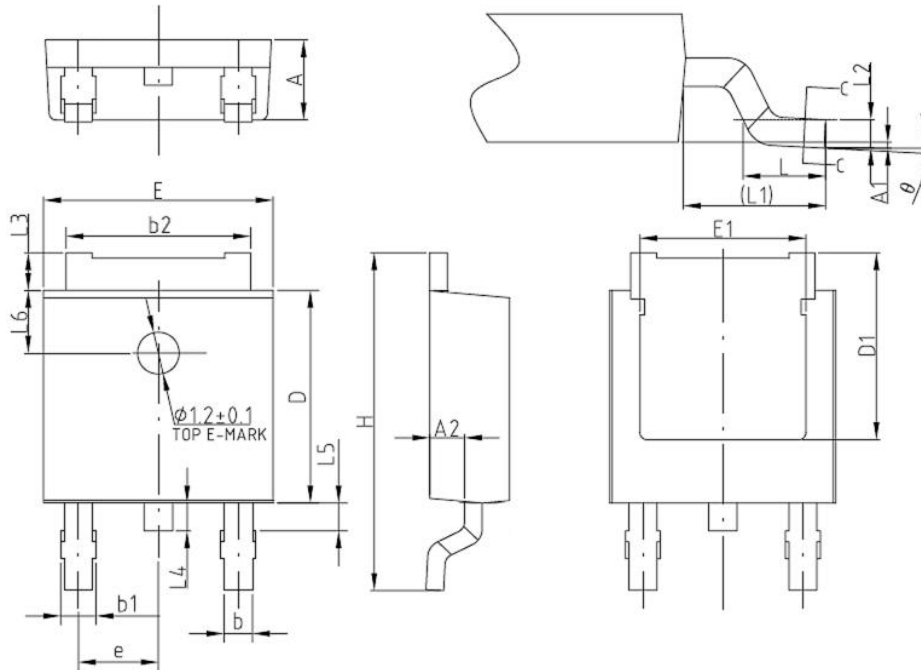
Mechanical Dimensions

SOP-8

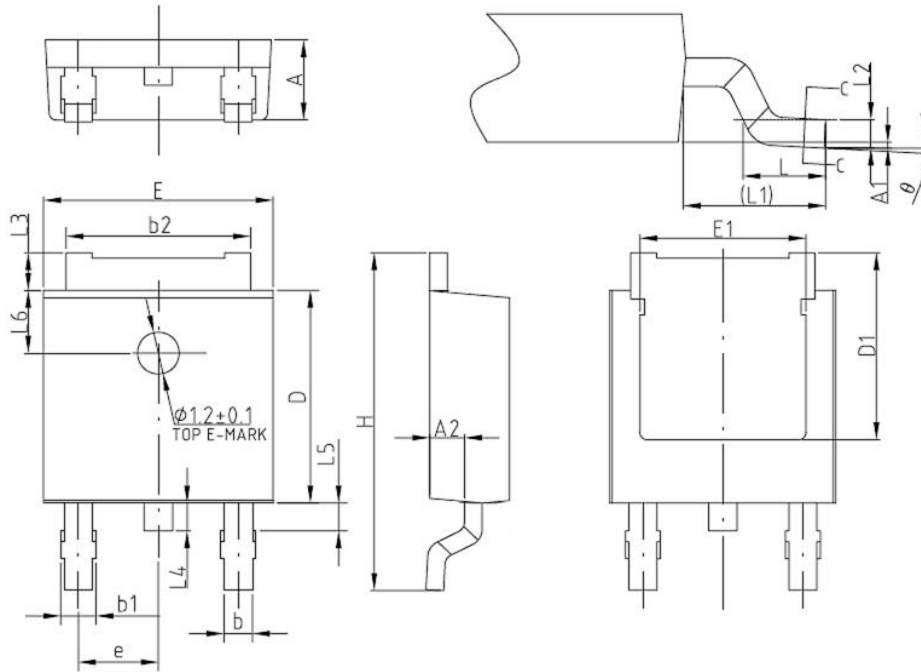
Unit: mm



Symbol	Dimensions(mm)		
	Min.	Typ.	Max.
A	1.35	1.55	1.75
A1	0.05	0.15	0.25
A2	1.25	1.40	1.65
b	0.31	-	0.51
c	0.10	-	0.26
D	4.70	4.90	5.15
E	3.70	3.90	4.10
E1	5.80	6.00	6.20
e	1.27(BSC)		
L	0.40	-	1.27
θ	0°	-	8°

Mechanical Dimensions
TO-252
Unit: mm


Symbol	Dimensions(mm)		
	Min.	Typ.	Max.
A	2.20	2.30	2.40
A1	0	-	0.10
A2	0.90	1.00	1.17
b	0.70	0.76	0.90
b1	0.77	-	1.10
b2	5.13	5.33	5.46
c	0.45	-	0.60
D	5.95	6.10	6.25
D1	-	5.30	-
E	6.45	6.60	6.75
E1	-	4.80	-
e	2.286(BSC)		
H	9.70	10.10	10.40
L	1.25	1.50	1.75
L1	-	2.90	-
L2	-	0.51	-
L3	0.90	-	1.25
L4	-	0.80	-
L5	-	1.00	-
L6	-	1.80	-
θ	0°	-	8°

Mechanical Dimensions
TO-252
Unit: mm


Symbol	Dimensions(mm)		
	Min.	Typ.	Max.
A	2.20	2.30	2.40
A1	0	-	0.10
A2	0.90	1.00	1.17
b	0.70	0.76	0.90
b1	0.77	-	1.10
b2	5.13	5.33	5.46
c	0.45	-	0.60
D	5.95	6.10	6.25
D1	-	5.30	-
E	6.45	6.60	6.75
E1	-	4.80	-
e	2.286(BSC)		
H	9.70	10.10	10.40
L	1.25	1.50	1.75
L1	-	2.90	-
L2	-	0.51	-
L3	0.90	-	1.25
L4	-	0.80	-
L5	-	1.00	-
L6	-	1.80	-
θ	0°	-	8°



Sanrise Technology Limited Company

<http://www.sanrise-tech.com>

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Main Site:

- Headquarter

Shenzhen Sanrise Technology Co., LTD.

A1206, Skyworth building, No. 008, gaoxinnan 1st Road,
Gaoxin District, Yuehai street,, Nanshan District, ShenZhen,
P.R.China

Tel: +86-755-22953335

Fax: +86-755-22916878

- Shanghai Office

Sanrise Technology Limited Company

Rm.401, Building B, No. 666, Zhangheng Road,
Zhangjiang Hi-Tech Park, Shanghai, P.R.China

Tel: +86-21-68825918